

Home | Login | Logout | Access Information | Alerts |

		Welcome United States Patent and Trademark Office							
□ Search Re	<del></del>		Е	ROWSE	SEARCH	IEE	E XPLORE GUIDE		
Your searc	"( ( ansys <in>metadata ) h matched 13 of 1235066 on of 100 results are display</in>	documents.						<b>⊡</b> e-mail	
» Search O	ptions								
View Session History			Modify Search						
New Search		( ( ans	( ( ansys <in>metadata ) <and> ( temperature<in>metadata ) )<and> ( semiconductor &gt;&gt;&gt;</and></in></and></in>						
		□с	heck	to searc	h only within t	nis results set			
» Key		Displ	ay Fo	ormat:	© Citation	C Citation & Ab	stract		
IEEE JNL	IEEE Journal or Magazine	Select	Art	icle Info	rmation				
IEE JNL	IEE Journal or Magazine								
IEEE CNF	IEEE Conference Proceeding		<ol> <li>Temperature and stress distribution in the SOI structure during factoring Cher Ming Tan; Zhenghao Gan; Xiaofang Gao; Semiconductor Manufacturing, IEEE Transactions on Volume 16, Issue 2, May 2003 Page(s):314 - 318</li> </ol>						
IEE CNF	IEE Conference Proceeding								
IEEE STD	IEEE Standard					0.1109/TSM.2003 		IEEE INI	
				.bou.dou	us   Notoreno	23   1 dii 1ext. <u>1 D1</u> (	,004 ND)	ILLE JNL	
			P C P oi V	ape, H.; ompone ackagino n] olume 2	Schweitzer, D nts and Packa and Manufac , Issue 3, Se	.; Janssen, J.H.J.; i ging Technologies,	Morelli, A. IEEE Tra Part A: P i30 - 538	ansactions on [see also Cc ackaging Technologies, IE	
		•	<u>A</u>	<u>bstractP</u>	us   Reference	es   Full Text: <u>PDF</u> (	1040 KB)	IEEE JNL	
			M E V	ling-Chu lectronic olume 39	n Hsieh; Yean s Letters ),  Issue 8,  17	red sensor with te -Kuen Fang; Pei-M April 2003 Page(s 0.1049/el:2003044	ing Wu; V ):656 - 65	•	
			Α	bstractP	us   Full Text:	PDF(344 KB) IEI	E JNL		
			ai Sa Ti Ca	n <b>d temp</b> aran, A.; RANSDL onferenc	e <b>rature senso</b> Abeysinghe, I ICERS, Solid- e on, 2003	ors onto optical fil D.C.; Deshmukh, P	oers .; Flennike uators and	egrating MEMS based of en, R.; Boyd, J.T.; d Microsystems, 12th Inte	
			A	ostractPl	us   Full Text:	<u>PDF(363 KB)</u> IEI	E CNF		
			tra	ansient	electrotherma	scillations in over Il circuit simulatio .T.; Rodamaker, M	n	ture protection of a pow	

Symposium on

18-20 May 1993 Page(s):304 - 309

Digital Object Identifier 10.1109/ISPSD.1993.297143

Power Semiconductor Devices and ICs, 1993. ISPSD '93. Proceedings of the !

## 13. Double-Sided IPEM Cooling Using Miniature Heat Pipes

Martens T. J.; Nellis G. F.; Pfotenhauer J. M.; Jahns T. M.;

IEEE Transactions on Components and Packaging Technologies : Accepted for publication

Volume PP, Issue 99, 2005 Page(s):1 - 10

Digital Object Identifier 10.1109/TCAPT.2005.848591

AbstractPlus | Full Text: PDF(1704 KB) | IEEE JNL

Indexed by #Inspec Help Contact Us Privacy &: © Copyright 2005 IEEE -